TPS7A33 –36V、1A、超低噪声负电压稳压器

1 特性

- 输入电压范围：–3V 至 –36V
- 噪声：
  - 16μV_{RMS}（10Hz 至 100kHz）
- 电源纹波抑制：
  - 72dB (10kHz)
- 可调输出：–1.18V 至 –33V
- 最大输出电流：1A
- 与 ≥ 10μF 的陶瓷电容搭配使用时可保持稳定
- 内置电流值限制和热关断保护
- 采用外部散热，高耐热性能 TO-220 封装
- 工作温度范围：
  –40°C 至 125°C

2 应用

- 用于运算放大器，数模转换器 (DAC)，模数转换器 (ADC)，和其他高精度模拟电路的电源轨
- 音频
- 后置 DC/DC 转换器稳压和纹波滤除
- 测试和测量
- 医疗
- 工业仪表
- 基站和电信基础设施
- 12V 和 24V 工业总线

3 说明

TPS7A33 系列线性稳压器是负电压 (–36V)，超低噪声（16μV_{RMS}，72dB PSRR）线性稳压器，能够为最高 1A 负载供电。

TPS7A33 系列产品装有一个补偿金属氧化物半导体 (CMOS) 逻辑电平兼容使能引脚 (EN)，此引脚允许可由用户定制的电源管理方案。 其它提供的特性包括内置电流值限制和热关断以在故障情况下保护此器件和系统。

由于在设计中主要使用双极技术，TPS7A33 适合于高准确度，高精度测量仪器应用，在此类应用中，为了获得最大的系统性能，规整的电压轨很关键。 此特性使得此款器件非常适合为运算放大器，模数转换器 (ADC)，数模转换器 (DAC)，和其它高性能模拟电路供电。

此外，TPS7A33 系列线性稳压器适用于后置 DC/DC 转换器稳压。 通过滤除 DC/DC 开关转换所固有的输出电压纹波，可确保在灵敏仪器仪表、医疗、测试和测量、音频和射频 (RF) 应用中实现系统性能最优化。

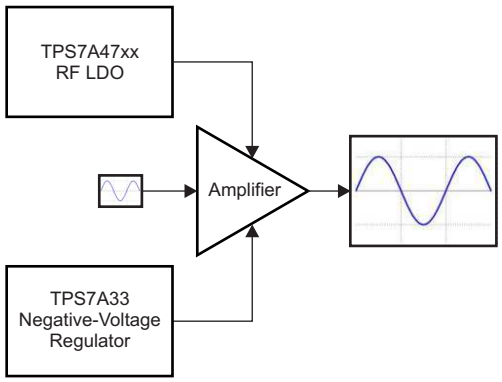
对于需要正负高性能电源轨的应用，还可以考虑采用 TPS7A4700 正向高电压、超低噪声、低压降线性稳压器。

器件信息(1)

器件型号	封装	封装尺寸（标称值）
TPS7A33	TO-220 (7)	10.17mm x 8.38mm
	超薄四方扁平无引线封装 (VQFN) (20)	5.00mm x 5.00mm

(1) 要了解所有可用封装，请见数据表末尾的可订购产品附录。

典型应用电路原理图



PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of the Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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4 修订历史记录

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (February 2013) to Revision D **Page**

- 已添加 *ESD 额定值表*，*特性描述*部分，*器件功能模式*，*应用和实施*部分，*电源相关建议*部分，*布局*部分，*器件和文档支持*部分以及*机械、封装和可订购信息*部分 ... 1
- 已更正数据表标题以显示精确的最大输出电流；将“–1A”更改为“1A” ... 1
- 已更改 首页图并已删除声明 RGW 封装处于产品预览状态的注释 ... 1
- Changed *Pin Configuration and Functions* section; updated table format and deleted footnote about RGW product-preview status ... 4
- Deleted footnote from Pin Functions table indicating RGW product-preview status ... 4
- Deleted footnote (2) from *Absolute Maximum Ratings* table ... 5
- Deleted note from *Thermal Information* table stating that RGW package was product preview ... 5
- Corrected condition values for Figure 23 ... 9
- Corrected condition values for Figure 24 ... 9
- Corrected condition values and trace indicators for Figure 25 ... 10
- Corrected condition values and trace indicators for Figure 26 ... 10
- Changed C_{SS} value from 1 µF to 10 nF in Figure 27 ... 10
- Deleted *Parametric Measurement Information* section ... 12
- Revised *Functional Block Diagram* ... 12
- Changed first paragraph of *Adjustable Operation* section stating the device output voltage range ... 15
- Changed Equation 2 for clarity ... 15
- Changed last sentence of *Capacitor Recommendations* section ... 16
- Changed noise reduction capacitor value from 1 µF to 10 nF in first paragraph of *Power-Supply Rejection* section. ... 17
- Revised last paragraph of *Power-Supply Rejection* section ... 17
- Changed noise reduction capacitor value from 1 µF to 10 nF in second paragraph of *Output Noise* section. ... 17
- Added footnote (1) to Figure 32 ... 18
- Changed title for Figure 41 ... 23
- Changed title for Figure 42 ... 23
- Changed *Power Dissipation* section title to *Layout Guidelines for Thermal Performance and Heat Sink Selection* ... 24

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修订历史记录 (接下页)

- Revised wording in *Layout Guidelines for Thermal Performance* section for clarification 24

Changes from Revision B (March 2012) to Revision C **Page**

- 已更改 产品状态，从混合状态更改为量产数据 1
- 已添加 最后一段至*说明*部分 1
- 已更改 典型应用方框图 1
- Updated Figure 31 17

Changes from Revision A (December 2011) to Revision B **Page**

- 已更改 产品状态，从量产数据更改为混合状态 1
- 已添加 RGW 引脚图 1
- Added RGW pinout drawing to *Pin Configuration and Functions* section 4
- Added RGW and footnote 1 to Pin Functions table 4
- Added RGW column to *Thermal Information* table 5

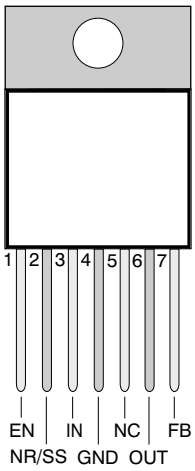
Changes from Original (December 2011) to Revision A **Page**

- 已更改 产品状态，从产品预览更改为量产数据 1

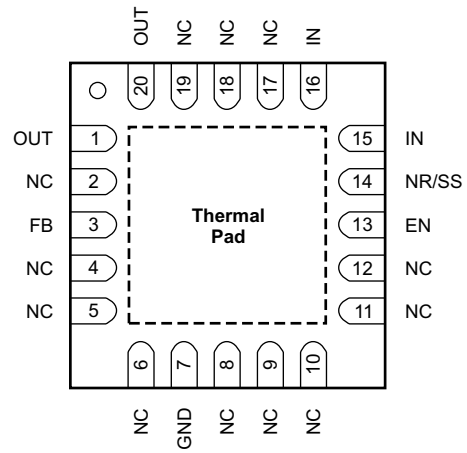
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5 Pin Configuration and Functions

KC Package
7-Pin TO-220
Top View



RGW Package
20-Pin VQFN
Top View



Pin Functions

PIN			I/O	DESCRIPTION
NAME	TO-220	VQFN		
EN	1	13	I	This pin turns the regulator on or off. If $V_{EN} \geq V_{EN(+HI)}$ or $V_{EN} \leq V_{EN(-HI)}$, the regulator is enabled. If $V_{EN(+LO)} \geq V_{EN} \geq V_{EN(-LO)}$, the regulator is disabled. The EN pin can be connected to IN, if not used. $\lvert V_{EN} \rvert \leq \lvert V_{IN} \rvert$.
FB	7	3	I	This pin is the input to the control-loop error amplifier. It is used to set the output voltage of the device. TI recommends connecting a 10-nF capacitor from FB to OUT (as close to the device as possible) to maximize AC performance.
GND	4	7	—	Ground
IN	3	15, 16	I	Input supply. A capacitor greater than or equal to 10 nF must be tied from this pin to ground to assure stability. It is recommended to connect a 10-µF capacitor from IN to GND (as close to the device as possible) to reduce circuit sensitivity to printed-circuit-board (PCB) layout, especially when long input traces or high source impedances are encountered.
NC	5	2, 4-6, 8-12, 17-19	—	This pin can be left open or tied to any voltage between GND and IN.
NR/SS	2	14	—	Noise reduction pin. A capacitor connected from this pin to GND controls the soft-start function and allows RMS noise to be reduced to very low levels. TI recommends connecting a 1-µF capacitor from NR/SS to GND (as close to the device as possible) to filter the noise generated by the internal bandgap and maximize ac performance.
OUT	6	1, 20	O	Regulator output. A capacitor greater than or equal to 10 µF must be tied from this pin to ground to assure stability. TI recommends connecting a 47-µF ceramic capacitor from OUT to GND (as close to the device as possible) to maximize ac performance.
Thermal Pad	Tab	—	—	Connect the thermal pad to a large-area ground plane. The thermal pad is internally connected to GND. An external heatsink can be installed to provide additional thermal performance.

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
Voltage	IN pin to GND pin	–36	0.3	V
	OUT pin to GND pin	–33	0.3	
	OUT pin to IN pin	–0.3	36	
	FB pin to GND pin	–2	0.3	
	FB pin to IN pin	–0.3	36	
	EN pin to GND pin	–36	10	
	NR/SS pin to IN pin	–0.3	36	
	NR/SS pin to GND pin	–2	0.3	
Current	Peak output	Internally limited		
Temperature	Operating virtual junction, T_J	–40	150	°C
	Storage temperature, T_{stg}	–65	150	

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	±1000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	±500	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Input supply voltage	–35		–3	V
V_{EN}	Enable supply voltage	V_{IN}		10	V
V_{OUT}	Output voltage	–33.2		V_{REF}	V
I_{OUT}	Output current	0		1	A
R_2 (1)	R_2 is the lower feedback resistor			240	kΩ
C_{IN}	Input capacitor	10	47		µF
C_{OUT}	Output capacitor	10	47		µF
C_{NR}	Noise reduction capacitor		1		µF
C_{FF}	Feed-forward capacitor		10		nF
T_J	Operating junction temperature	–40		125	°C

(1) This condition helps ensure stability at no load.

6.4 Thermal Information

THERMAL METRIC (1)		TPS7A33		UNIT
		KC (TO-220)	RGW (VQFN)	
		7 PINS	20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	31.2	33.7	°C/W
$R_{\theta JC(top)}$	Junction-to-case(top) thermal resistance	40	30.4	
$R_{\theta JB}$	Junction-to-board thermal resistance	17.4	12.5	
ψ_{JT}	Junction-to-top characterization parameter	6.4	0.4	
ψ_{JB}	Junction-to-board characterization parameter	17.2	12.5	
$R_{\theta JC(bot)}$	Junction-to-case(bottom) thermal resistance	0.8	2.4	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.

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6.5 Electrical Characteristics

At –40°C ≤ T_J ≤ 125°C, $|V_{IN}| = |V_{OUT(nom)}| + 1$ V or $|V_{IN}| = 3$ V (whichever is greater), $V_{EN} = V_{IN}$, $I_{OUT} = 1$ mA, $C_{IN} = 10$ µF, $C_{OUT} = 10$ µF, $C_{NR/SS} = 0$ nF, and FB tied to OUT, unless otherwise noted.(1)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{IN}	Input voltage		–35		–3	V
V_{REF}	Internal reference	T_J = 25°C, $V_{FB} = V_{REF}$	–1.192	–1.175	–1.157	V
V_{UVLO}	Undervoltage lockout threshold			–2		V
V_{OUT}	Output voltage range(2)	$\|V_{IN}\| \geq \|V_{OUT(nom)}\| + 1$ V	–33.2		V_{REF}	V
	Nominal accuracy	T_J = 25°C, $\|V_{IN}\| = \|V_{OUT(nom)}\| + 0.5$ V	–1.5		1.5	$\%V_{OUT}$
	Overall accuracy	5 V ≤ $\|V_{IN}\|$ ≤ 35 V 1 mA ≤ I_{OUT} ≤ 1 A		±1		$\%V_{OUT}$
		$\|V_{OUT(nom)}\| + 1$ V ≤ $\|V_{IN}\|$ ≤ 35 V 1 mA ≤ I_{OUT} ≤ 1 A	–2.5		2.5	
$\Delta V_{OUT(\Delta VI)}$	Line regulation	$\|V_{OUT(nom)}\| + 1$ V ≤ $\|V_{IN}\|$ ≤ 35 V		0.14		$\%V_{OUT}$
$\Delta V_{OUT(\Delta IL)}$	Load regulation	1 mA ≤ I_{OUT} ≤ 1 A		0.4		$\%V_{OUT}$
$\|V_{DO}\|$	Dropout voltage	V_{IN} = 95% $V_{OUT(nom)}$, I_{OUT} = 500 mA		290		mV
		V_{IN} = 95% $V_{OUT(nom)}$, I_{OUT} = 1 A		325	800	
I_{CL}	Current limit	V_{OUT} = 90% $V_{OUT(nom)}$		1900		mA
I_{GND}	Ground current	I_{OUT} = 0 mA		210	350	µA
		I_{OUT} = 500 mA		5		mA
$\|I_{SHDN}\|$	Shutdown supply current	V_{EN} = +0.4 V		1	3	µA
		V_{EN} = –0.4 V		1	3	
I_{FB}	Feedback current(3)			14	100	nA
$\|I_{EN}\|$	Enable current	$V_{EN} = \|V_{IN}\| = \|V_{OUT(nom)}\| + 1$ V		0.48	1	µA
		$V_{IN} = V_{EN}$ = –35 V		0.51	1	
		V_{IN} = –35 V, V_{EN} = +10 V		0.5	1	
$V_{EN(+HI)}$	Positive enable high-level voltage		2		10	V
$V_{EN(+LO)}$	Positive enable low-level voltage		0		0.4	V
$V_{EN(–HI)}$	Negative enable high-level voltage		V_{IN}		–2	V
$V_{EN(–LO)}$	Negative enable low-level voltage		–0.4		0	V
V_n	Output noise voltage	V_{IN} = –3 V, $V_{OUT(nom)} = V_{REF}$, C_{OUT} = 22 µF, $C_{NR/SS}$ = 10 nF, BW = 10 Hz to 100 kHz		16		μV_{RMS}
PSRR	Power-supply rejection ratio	V_{IN} = –6.2 V, $V_{OUT(nom)}$ = –5 V, C_{OUT} = 22 µF, $C_{NR/SS}$ = 10 nF, C_{FF}(4) = 10 nF, f = 10 kHz		72		dB
T_{sd}	Thermal shutdown temperature	Shutdown, temperature increasing		170		°C
		Reset, temperature decreasing		150		°C
T_J	Operating junction temperature		–40		125	°C

(1) At operating conditions, $V_{IN} \leq 0$ V, $V_{OUT(nom)} \leq V_{REF} \leq 0$ V. At regulation, $V_{IN} \leq V_{OUT(nom)} - |V_{DO}|$. $I_{OUT} > 0$ flows from OUT to IN.
(2) To ensure stability at no load conditions, a current from the feedback resistive network equal to or greater than 5 µA is required.
(3) $I_{FB} > 0$ flows into the device.
(4) C_{FF} refers to a feed-forward capacitor connected between the FB and OUT pins.

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6.6 Typical Characteristics

At –40°C ≤ T_J ≤ 125°C, $|V_{IN}| = |V_{OUT(nom)}| + 1$ V or $|V_{IN}| = 3$ V (whichever is greater), $V_{EN} = V_{IN}$, $I_{OUT} = 1$ mA, $C_{IN} = 22$ µF, $C_{OUT} = 22$ µF, $C_{NR/SS} = 0$ nF, and the FB pin tied to OUT, unless otherwise noted.

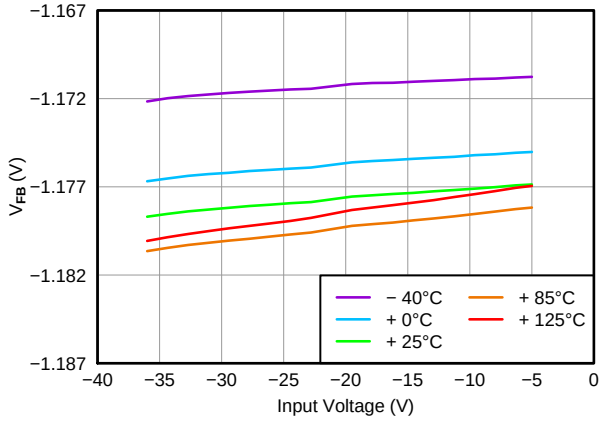


Figure 1. Feedback Voltage vs Input Voltage

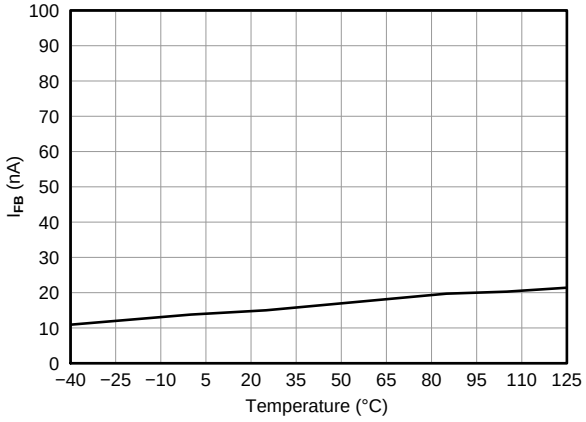


Figure 2. Feedback Current vs Temperature

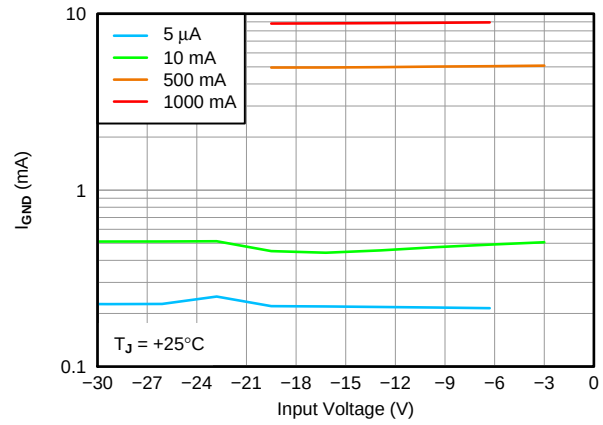


Figure 3. Ground Current vs Input Voltage

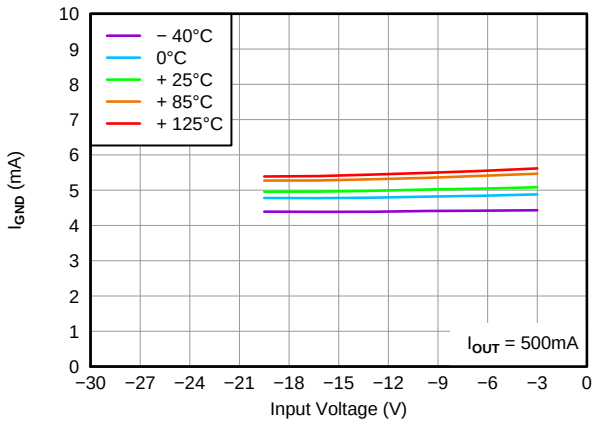


Figure 4. Ground Current vs Input Voltage

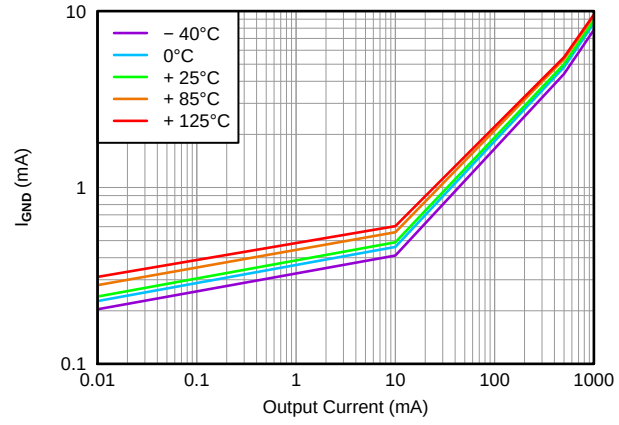


Figure 5. Ground Current vs Output Current

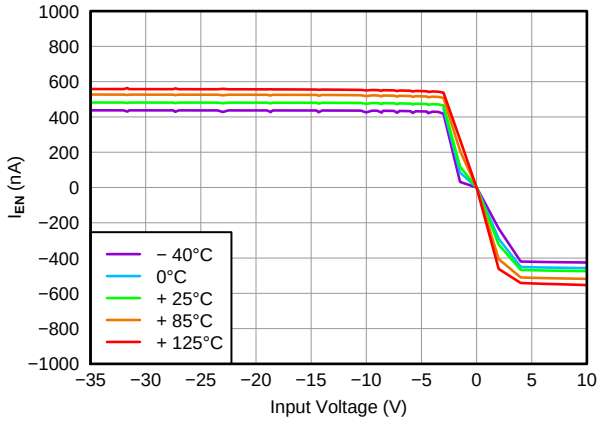


Figure 6. Enable Current vs Enable Voltage

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Typical Characteristics (continued)

At –40°C ≤ T_J ≤ 125°C, $|V_{IN}| = |V_{OUT(nom)}| + 1$ V or $|V_{IN}| = 3$ V (whichever is greater), $V_{EN} = V_{IN}$, $I_{OUT} = 1$ mA, $C_{IN} = 22$ µF, $C_{OUT} = 22$ µF, $C_{NR/SS} = 0$ nF, and the FB pin tied to OUT, unless otherwise noted.

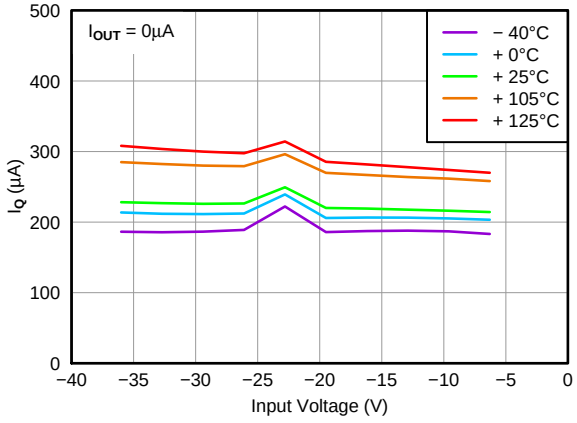


Figure 7. Quiescent Current vs Input Voltage

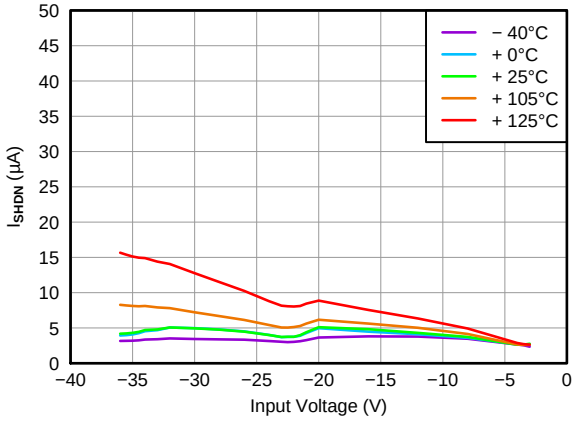


Figure 8. Shutdown Current vs Input Voltage

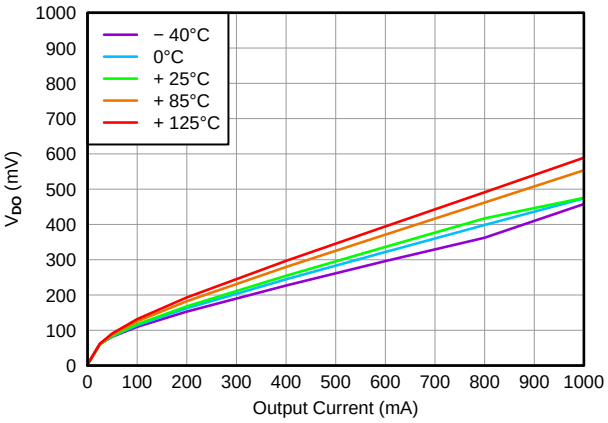


Figure 9. Dropout Voltage vs Output Current

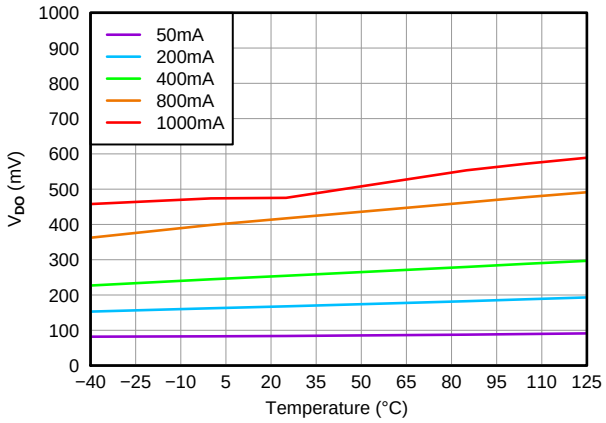


Figure 10. Dropout Voltage vs Temperature

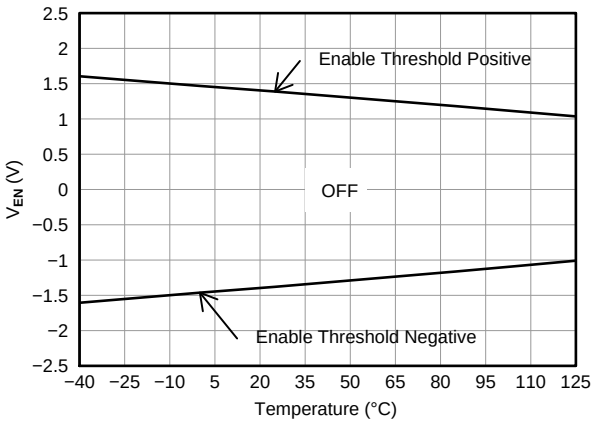


Figure 11. Enable Threshold Voltage vs Temperature

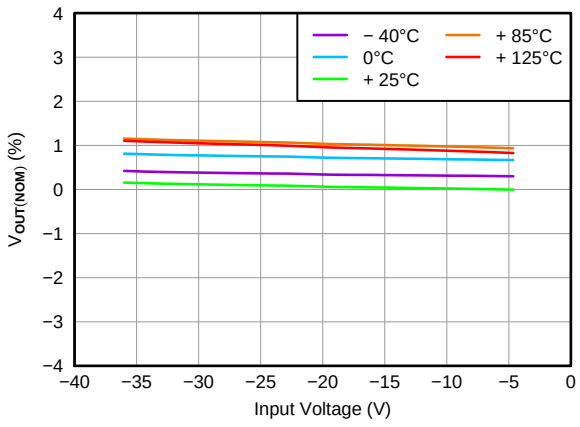


Figure 12. Line Regulation

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Typical Characteristics (continued)

At –40°C ≤ T_J ≤ 125°C, $|V_{IN}| = |V_{OUT(nom)}| + 1$ V or $|V_{IN}| = 3$ V (whichever is greater), $V_{EN} = V_{IN}$, $I_{OUT} = 1$ mA, $C_{IN} = 22$ µF, $C_{OUT} = 22$ µF, $C_{NR/SS} = 0$ nF, and the FB pin tied to OUT, unless otherwise noted.

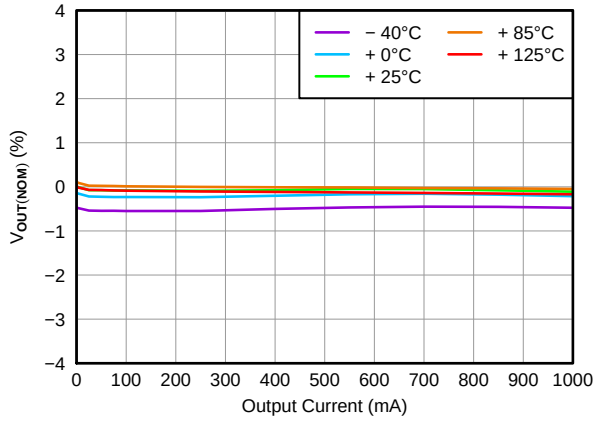


Figure 13. Load Regulation

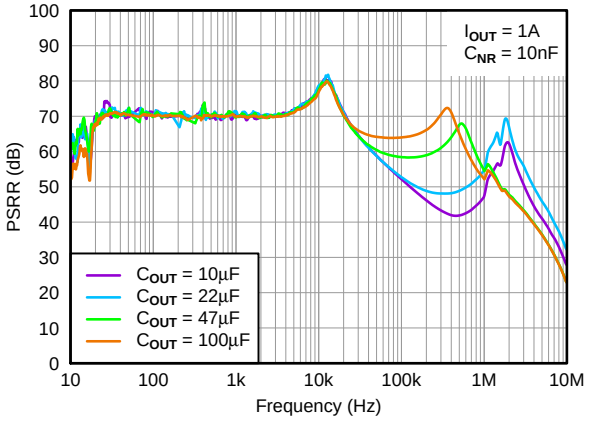


Figure 14. Power-Supply Rejection Ratio vs C_{OUT}

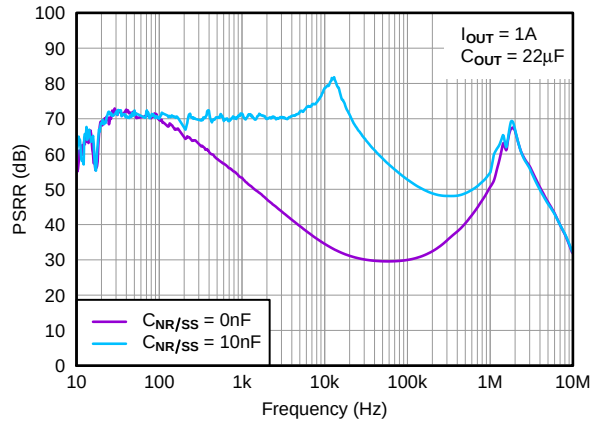


Figure 15. Power-Supply Rejection Ratio vs $C_{NR/SS}$

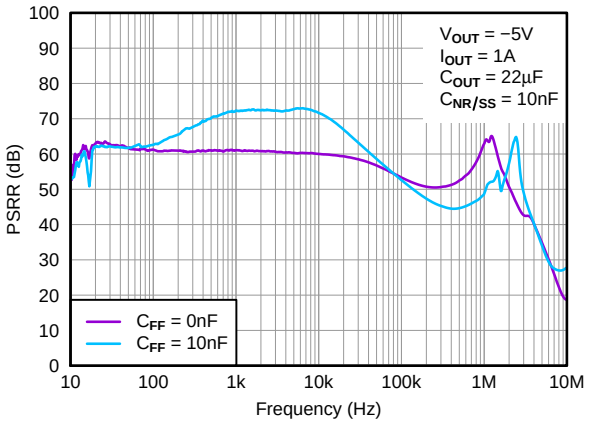


Figure 16. Power-Supply Rejection Ratio vs C_{FF}

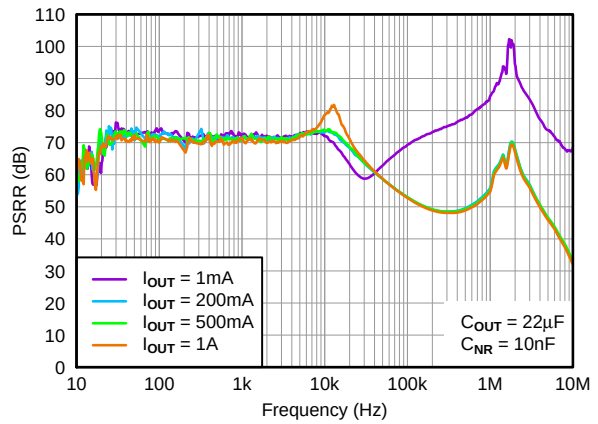


Figure 17. Power-Supply Rejection Ratio vs I_{OUT}

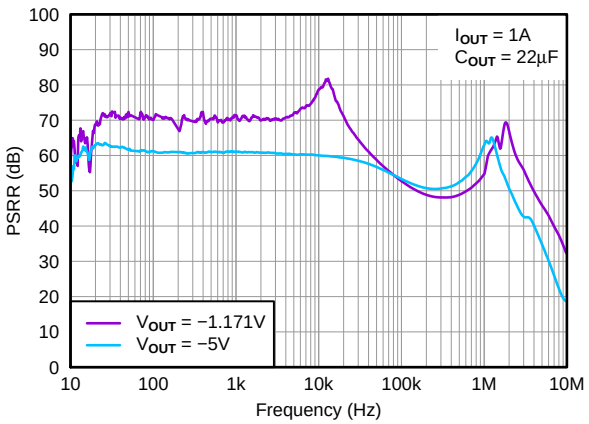


Figure 18. Power-Supply Rejection Ratio vs V_{OUT}

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Typical Characteristics (continued)

At –40°C ≤ T_J ≤ 125°C, $|V_{IN}| = |V_{OUT(nom)}| + 1$ V or $|V_{IN}| = 3$ V (whichever is greater), $V_{EN} = V_{IN}$, $I_{OUT} = 1$ mA, $C_{IN} = 22$ µF, $C_{OUT} = 22$ µF, $C_{NR/SS} = 0$ nF, and the FB pin tied to OUT, unless otherwise noted.

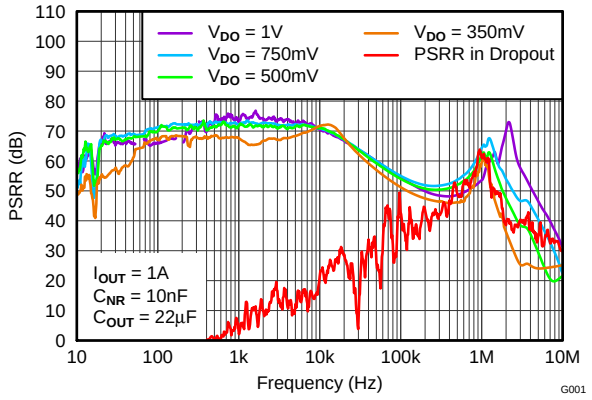


Figure 19. Power-Supply Rejection Ratio vs V_{DO}

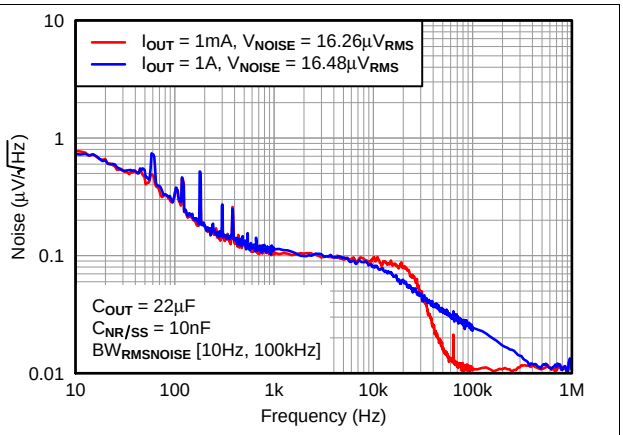


Figure 20. Output Spectral Noise Density vs Output Current

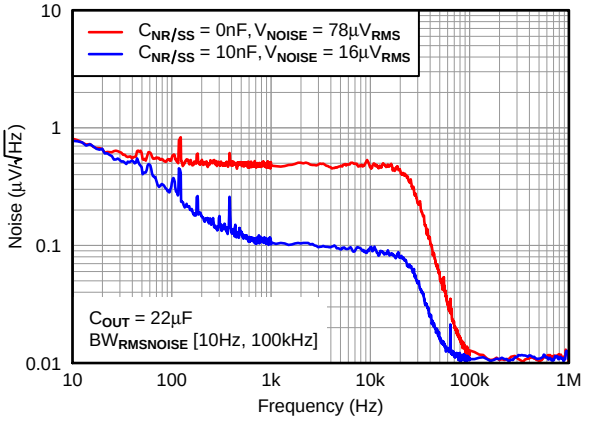


Figure 21. Output Spectral Noise Density vs $C_{NR/SS}$

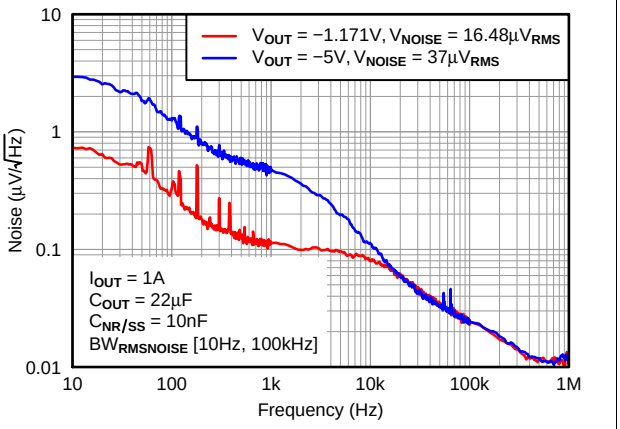


Figure 22. Output Spectral Noise Density vs $V_{OUT(nom)}$

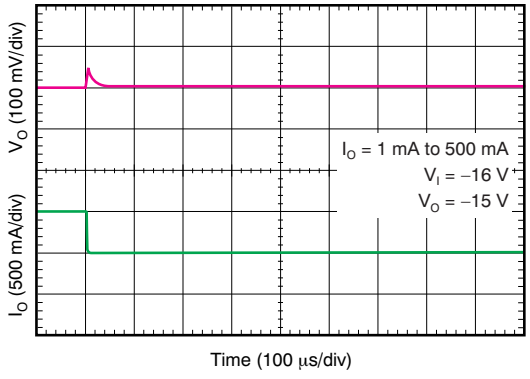


Figure 23. Load Transient

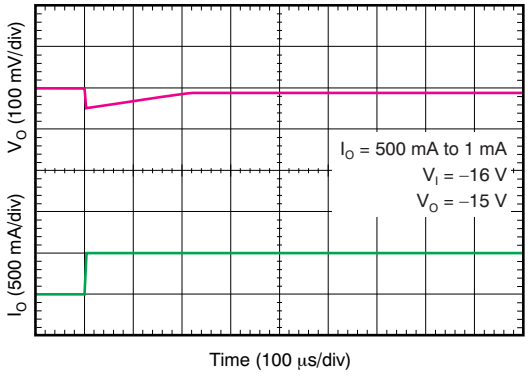


Figure 24. Load Transient

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Typical Characteristics (continued)

At –40°C ≤ T_J ≤ 125°C, $|V_{IN}| = |V_{OUT(nom)}| + 1$ V or $|V_{IN}| = 3$ V (whichever is greater), $V_{EN} = V_{IN}$, $I_{OUT} = 1$ mA, $C_{IN} = 22$ µF, $C_{OUT} = 22$ µF, $C_{NR/SS} = 0$ nF, and the FB pin tied to OUT, unless otherwise noted.

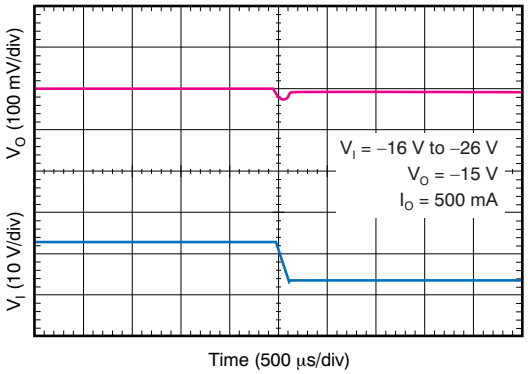


Figure 25. Line Transient

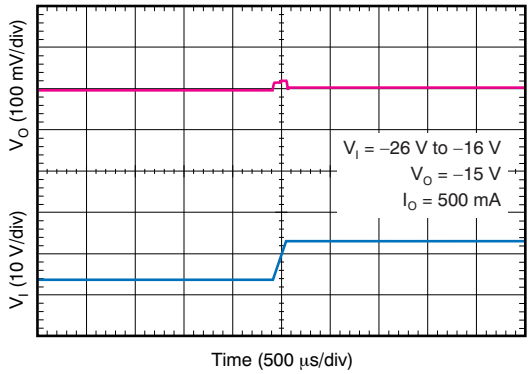


Figure 26. Line Transient

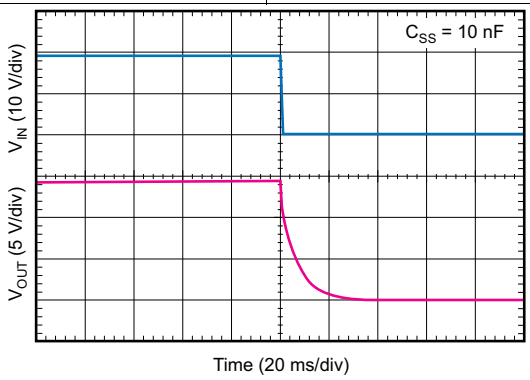


Figure 27. Capacitor-Programmable Soft-Start

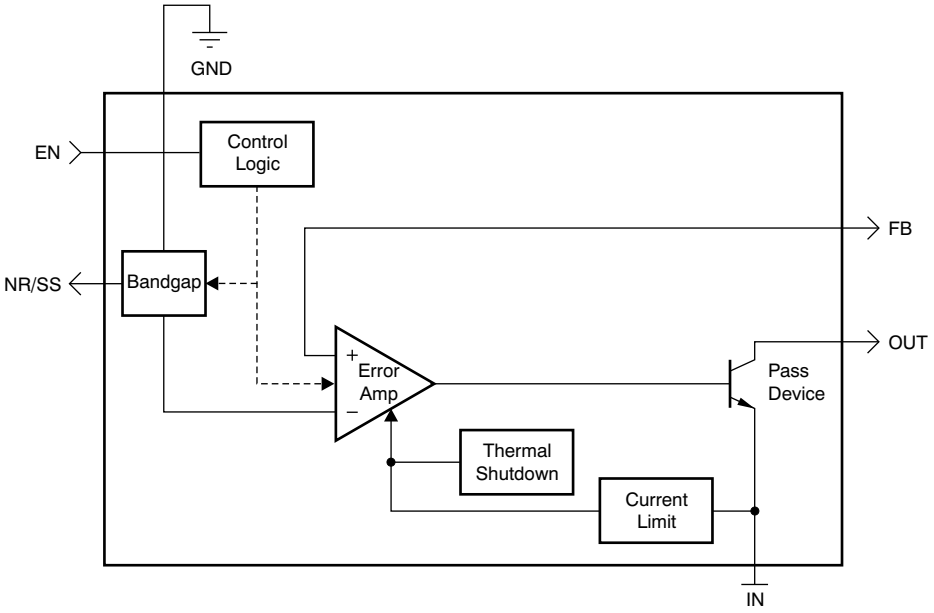
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7 Detailed Description

7.1 Overview

The TPS7A33 belongs to a family of new-generation linear regulators that use an innovative bipolar process to achieve ultralow-noise and very high PSRR levels at a wide input voltage and current range. These features, combined with the external heatsink-capable, high thermal performance TO-220 package, make this device ideal for high-performance analog applications.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Internal Current Limit

The fixed internal current limit of the TPS7A33xx family helps protect the regulator during fault conditions. The maximum amount of current the device can source is the current limit (1.9 A, typical), and it is largely independent of output voltage. For reliable operation, do not operate the device in current limit for extended periods of time.

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Feature Description (continued)

7.3.2 Enable Pin Operation

The TPS7A33 provides a dual-polarity enable pin (EN) that turns on the regulator when $|V_{EN}| > 2$ V, whether the voltage is positive or negative, as shown in Figure 28.

This functionality allows for different system power management topologies; for example:

- Connecting the EN pin directly to a negative voltage, such as V_{IN}, or
- Connecting the EN pin directly to a positive voltage, such as the output of digital logic circuitry.

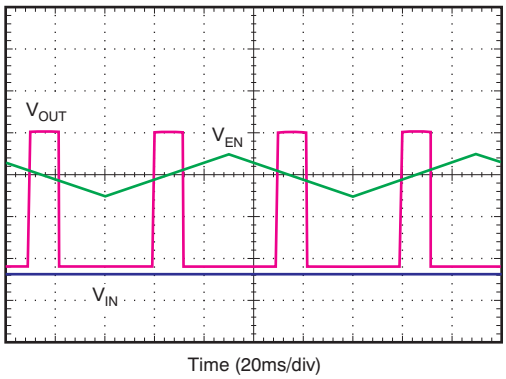


Figure 28. Enable Pin Positive and Negative Threshold

7.3.3 Programmable Soft-Start

The NR capacitor also acts as a soft-start capacitor to slow down the rise time of the output. The output rise time, when using an NR capacitor, is governed by Equation 1.

$$t_{SS}\ (\text{ms}) = 1.2 \times C_{NR}\ (\text{nF}) \quad (1)$$

In Equation 1, t_{SS} is the soft-start time in milliseconds, and $C_{NR/SS}$ is the capacitance at the NR pin in nanofarads.

Figure 29 shows the start-up voltage waveforms versus $C_{NR/SS}$.

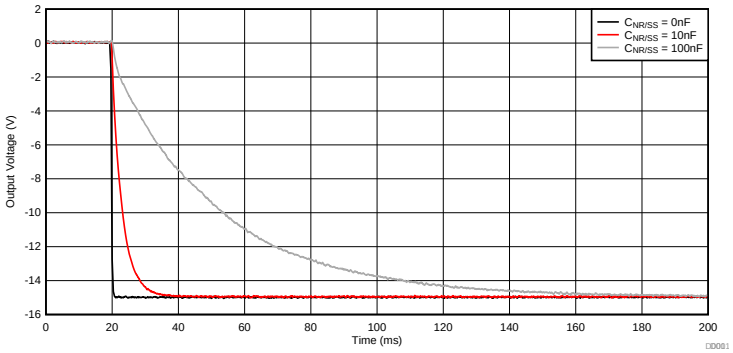


Figure 29. Start-Up vs $C_{NR/SS}$

7.3.4 Thermal Protection

Thermal protection disables the output when the junction temperature rises to approximately 170°C, allowing the device to cool. When the junction temperature cools to approximately 150°C, the output circuitry is enabled. Depending on power dissipation, thermal resistance, and ambient temperature, the thermal protection circuit may cycle on and off. This cycling limits the dissipation of the regulator, protecting it from damage as a result of overheating.

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Feature Description (continued)

Any tendency to activate the thermal protection circuit indicates excessive power dissipation or an inadequate heat sink. For reliable operation, junction temperature should be limited to a maximum of 125°C. To estimate the margin of safety in a complete design (including heat sink), increase the ambient temperature until the thermal protection is triggered; use worst-case loads and signal conditions. For good reliability, thermal protection should trigger at least 35°C above the maximum expected ambient condition of your particular application. This configuration produces a worst-case junction temperature of 125°C at the highest expected ambient temperature and worst-case load.

The internal protection circuitry of the TPS7A33 has been designed to protect against overload conditions. It was not intended to replace proper heatsinking. Continuously running the TPS7A33 into thermal shutdown degrades device reliability.

7.4 Device Functional Modes

7.4.1 Normal Operation

The device regulates to the nominal output voltage under the following conditions:

- The input voltage has previously exceeded the UVLO rising voltage and has not decreased below the UVLO falling threshold.
- The input voltage is greater than the nominal output voltage added to the dropout voltage.
- $|V_{EN}| > |V_{(HI)}|$
- The output current is less than the current limit.
- The device junction temperature is less than the maximum specified junction temperature.

7.4.2 Dropout Operation

If the input voltage magnitude is lower than the nominal output voltage magnitude plus the specified dropout voltage magnitude, but all other conditions are met for normal operation, the device operates in dropout mode. In this condition, the output voltage magnitude is the same as the input voltage magnitude minus the dropout voltage magnitude. The transient performance of the device is significantly degraded because the pass device (as a bipolar junction transistor, or BJT) is in saturation and no longer controls the current through the LDO. Line or load transients in dropout can result in large output voltage deviations.

7.4.3 Disabled

The device is disabled under the following conditions:

- $|V_{EN}| < |V_{(HI)}|$
- The device junction temperature is greater than the thermal shutdown temperature.

Table 1 shows the conditions that lead to the different modes of operation.

Table 1. Device Functional Mode Comparison

OPERATING MODE	PARAMETER			
	V_{IN}	V_{EN}	I_{OUT}	T_J
Normal mode	$\|V_{IN}\| > \{ \|V_{OUT(nom)}\| + \|V_{DO}\|, \|V_{IN(min)}\| \}$	$\|V_{EN}\| > \|V_{(HI)}\|$	$I_{OUT} < I_{CL}$	$T_J < 125°C$
Dropout mode	$\|V_{IN(min)}\| < \|V_{IN}\| < \|V_{OUT(nom)}\| + \|V_{DO}\|$	$\|V_{EN}\| > \|V_{(HI)}\|$	—	$T_J < 125°C$
Disabled mode (any true condition disables the device)	—	$\|V_{EN}\| < \|V_{(HI)}\|$	—	$T_J > 165°C$

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8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Adjustable Operation

The TPS7A3301 has an output voltage range of $-V_{REF}$ to –33 V. The nominal output voltage of the device is set by two external resistors, as shown in Figure 32.

R_1 and R_2 can be calculated for any output voltage range using Equation 2. To ensure stability under no-load conditions at $V_{OUT} > V_{REF}$, this resistive network must provide a current equal to or greater than 5 µA.

$$R_1 = R_2 \left(\frac{V_{OUT}}{V_{REF}} - 1 \right), \quad \text{where } \frac{|V_{REF(max)}|}{R_2} > 5\ \mu A \tag{2}$$

If greater voltage accuracy is required, consider the output voltage offset contributions because of the feedback pin current and use 0.1%-tolerance resistors.

Table 2 shows the resistor combinations to achieve a few of the most common rails using commercially available, 0.1%-tolerance resistors to maximize nominal voltage accuracy while adhering to the formula shown in Equation 2.

Table 2. Suggested Resistors For Common Voltage Rails

V_{OUT} (V)	R_1	R_2 (kΩ)	$V_{OUT}/(R_1+R_2)$ (µA)	NOMINAL ACCURACY
–1.171	0 Ω	∞	0	±1.5%
–1.8	76.8 kΩ	143	8.18	±(1.5% + 0.08%)
–3.3	200 kΩ	110	10.64	±(1.5% + 0.13%)
–5	332 kΩ	102	11.48	±(1.5% + 0.5%)
–10	1.62 MΩ	215	5.44	±(1.5% + 0.23%)
–12	1.5 MΩ	162	7.22	±(1.5% + 0.29%)
–15	1.24 MΩ	105	11.15	±(1.5% + 0.18%)
–18	3.09 MΩ	215	5.44	±(1.5% + 0.19%)
–24	1.15 MΩ	59	19.84	±(1.5% + 0.21%)

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8.1.2 Capacitor Recommendations

Low equivalent series resistance (ESR) capacitors should be used for the input, output, noise reduction, and bypass capacitors. Ceramic capacitors with X7R and X5R dielectrics are preferred. These dielectrics offer more stable characteristics. Ceramic X7R capacitors offer improved overtemperature performance, while ceramic X5R capacitors are the most cost-effective and are available in higher values.

NOTE

High-ESR capacitors may degrade PSRR and affect stability.

8.1.3 Input and Output Capacitor Requirements

The TPS7A33 family of negative, high-voltage linear regulators achieve stability with a minimum input and output capacitance of 10 µF; however, TI highly recommends using a 47-µF capacitor to maximize AC performance.

8.1.4 Noise Reduction and Feed-Forward Capacitor Requirements

Although the noise-reduction ($C_{NR/SS}$) and feed-forward (C_{FF}) capacitors are not needed to achieve stability, TI highly recommends using a 10-nF feed-forward capacitor and a 1-µF noise-reduction capacitor to minimize noise and maximize AC performance.

The feed-forward capacitor can also provide a soft-start effect, as detailed in the application note, *Pros and Cons of Using a Feed-Forward Capacitor with a Low Dropout Regulator*, SBVA042 (available for download from the TI website). Figure 30 shows device start-up with no $C_{NR/SS}$, C_{FF} = 10 nF, V_{IN} = –16 V, and V_{OUT} = –15 V.

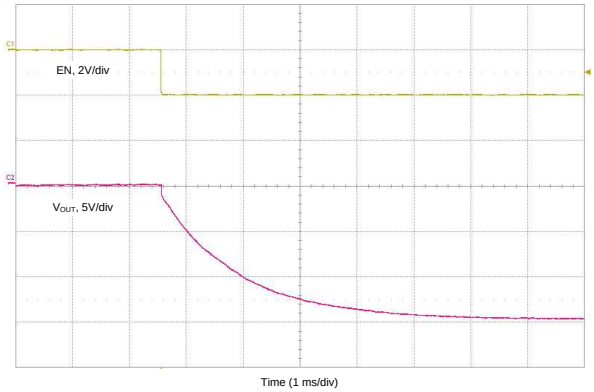


Figure 30. Start-up With a Feed-Forward Capacitor

8.1.5 Post DC-DC Converter Filtering

Most of the time, the voltage rails available in a system do not match the voltage specifications demanded by one or more of its circuits; these rails must be stepped up or down, depending on specific voltage requirements.

DC-DC converters are the preferred solution to stepping up or down a voltage rail when current consumption is not negligible. These devices offer high efficiency with minimum heat generation, but they have one primary disadvantage: they introduce a high-frequency component, and the associated harmonics, on top of the DC output signal.

If not filtered properly, this high-frequency component degrades analog circuitry performance, and reduces overall system accuracy and precision.

The TPS7A33 offers a wide-bandwidth, very-high power-supply rejection ratio (PSRR). This specification makes it ideal for post DC-DC converter filtering, as shown in Figure 31. TI highly recommends using the maximum performance schematic shown in Figure 32. Also, verify that the fundamental frequency (and its first harmonic, if possible) is within the bandwidth of the regulator PSRR, shown in Figure 16.

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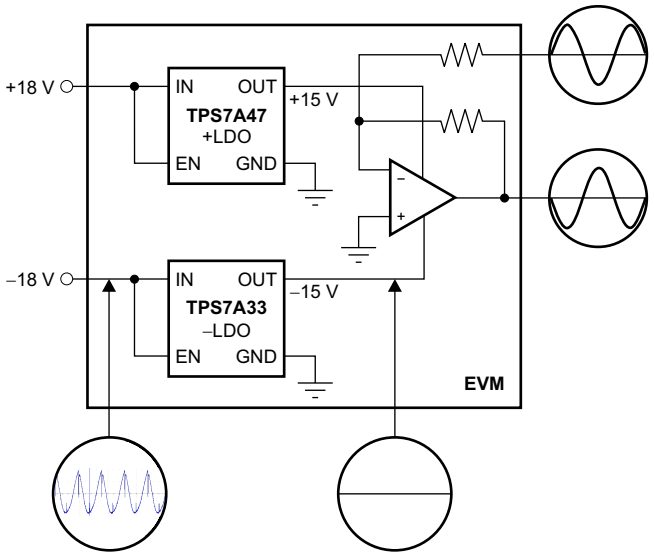


Figure 31. Post DC-DC Converter Regulation to High-Performance Analog Circuitry

8.1.6 Audio Applications

Audio applications are extremely sensitive to any distortion and noise in the audio band from 20 Hz to 20 kHz. This stringent requirement demands clean voltage rails to power critical high-performance audio systems.

The very high power-supply rejection ratio (> 60 dB) and low noise at the audio band of the TPS7A33 maximize performance for audio applications; see Figure 16.

8.1.7 Maximum AC Performance

To maximize noise and PSRR performance, TI recommends including 47-µF or higher input and output capacitors, 100-nF noise-reduction capacitors, and 10-nF feed-forward capacitors, as shown in Figure 32. The solution shown delivers minimum noise levels of 16 μV_{RMS} and power-supply rejection levels above 55 dB from 10 Hz to 1 MHz; see Figure 19.

8.1.8 Power-Supply Rejection

The 10-nF noise-reduction capacitor greatly improves TPS7A33 power-supply rejection, achieving up to 10 dB of additional power-supply rejection for frequencies between 140 Hz and 500 kHz.

Additionally, AC performance can be maximized by adding a 10-nF feed-forward capacitor (C_{FF}) from the FB pin to the OUT pin. This capacitor greatly improves power-supply rejection at lower frequencies, for the band from 100 Hz to 100 kHz; see Figure 15.

The high power-supply rejection of the TPS7A33 makes it a good choice for powering high-performance analog circuitry.

8.1.9 Output Noise

The TPS7A33 provides low output noise when a noise-reduction capacitor ($C_{NR/SS}$) is used.

The noise-reduction capacitor serves as a filter for the internal reference. By using a 10-nF noise reduction capacitor, the output noise is reduced by almost 80% (from 80 μV_{RMS} to 17 μV_{RMS}); see Figure 21.

The TPS7A33 low output voltage noise makes it an ideal solution for powering noise-sensitive circuitry.

8.1.10 Transient Response

As with any regulator, increasing the size of the output capacitor reduces overshoot and undershoot magnitude, but increases duration of the transient response.

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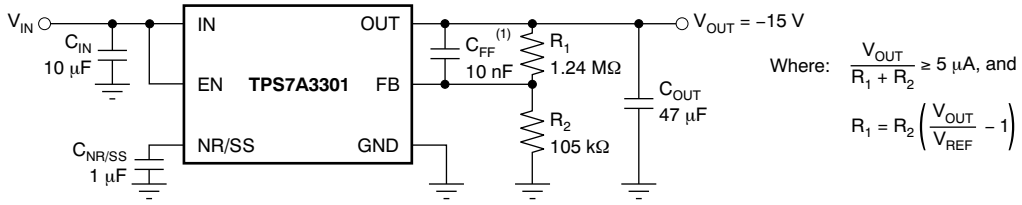
8.1.11 Power for Precision Analog

One of the primary TPS7A33 applications is to provide ultralow-noise voltage rails to high-performance analog circuitry in order to maximize system accuracy and precision.

The TPS7A33 family of negative, high-voltage linear regulators provides ultralow noise, positive and negative voltage rails to high-performance analog circuitry such as operational amplifiers, ADCs, DACs, and audio amplifiers.

Because of the ultralow noise levels at high voltages, analog circuitry with high-voltage input supplies can be used. This characteristic allows for high-performance analog solutions to optimize the voltage range, thus maximizing system accuracy.

8.2 Typical Application



A. Refer to application report *Pros and Cons of Using a Feed-forward Capacitor with a Low-Dropout Regulator*, SBVA042.

Figure 32. Adjustable Operation for Maximum AC Performance

8.2.1 Design Requirements

The design goals for this example are V_{IN} = –16 V, V_{OUT} = –15 V, and I_{OUT} = 1 A maximum. The design must optimize transient response, and the input supply comes from a supply on the same printed-circuit board (PCB).

8.2.2 Detailed Design Procedure

The design space consists of C_{IN}, C_{OUT}, $C_{SS/NR}$, R_1, R_2, and the circuit shown in Figure 32.

The first step when designing with a linear regulator is to examine the maximum load current along with the input and output voltage requirements to determine if the device thermal and dropout voltage requirements can be met. At 1 A, the input dropout voltage of the TPS7A33xx family is a maximum of 800 mV overtemperature; thus, the dropout headroom is sufficient for operation over both input and output voltage accuracy. Keep in mind that operating an LDO close to the dropout limit reduces AC performance, but has the benefit of reducing the power dissipation across the LDO.

The maximum power dissipated in the linear regulator is the maximum voltage drop across the pass element from the input to the output multiplied by the maximum load current. In this example, the maximum voltage drop across in the pass element is (–16 V) – (–15 V), giving us a V_{DROP} = 1 V. The power dissipated in the pass element is calculated by taking this voltage drop multiplied by the maximum load current. For this example, the maximum power dissipated in the linear regulator is approximately 1 W, and does not include the power consumed by the V_{BIAS} rail.

Once the power dissipated in the linear regulator is known, the corresponding junction temperature rise can be calculated. To calculate the junction temperature rise above ambient, the power dissipated must be multiplied by the junction-to-ambient thermal resistance. For thermal resistance information, refer to *Thermal Information* and *Thermal Performance and Heat Sink Selection*. For this example, using the RGW package, the maximum junction temperature rise is calculated to be 17.2°C. The maximum junction temperature rise is calculated by adding junction temperature rise to the maximum ambient temperature, which is 85°C. In this example, then, the maximum junction temperature is 102.2°C. The maximum junction temperate must be less than 125°C for reliable operation. Additional ground planes, added thermal vias, and air flow all combine to lower the maximum junction temperature.

To ensure an accurate output voltage, R_1 and R_2 must also be found, and the current through these resistors must be greater than 5 µA to ensure that the leakage into the device does not affect the accuracy. Using 1% resistors, and setting R_1 to 1 MΩ to minimize the current leakage while continuing to hold it above 5 µA, then use Equation 3 to calculate the proper value for R_2 and the divider current.

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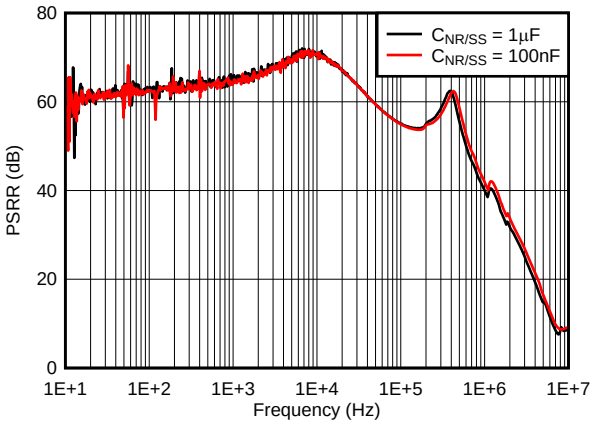
Typical Application (continued)

$$R2 = \frac{(R1 \bullet V_{REF})}{V_O - V_{REF}} = 85\ k\Omega \quad \text{and} \quad I_{DIVIDER} = \frac{V_O}{R1 + R2} = 13.8\ \mu A \tag{3}$$

For C_{IN}, assume that the –16 V supply has some inductance, and is placed several inches away from the PCB. For this case, select a 10-µF ceramic input capacitor to ensure that the input inductance is negligible to the regulator control loop while also keeping the physical size and cost of the capacitor low because it is a standard-value capacitor. C_{OUT} is set at 20 µF for AC performance, C_{FF} is set at 10 nF, and C_{NR} is set at 100 nF for optimal noise performance and to minimize the size of the external capacitor.

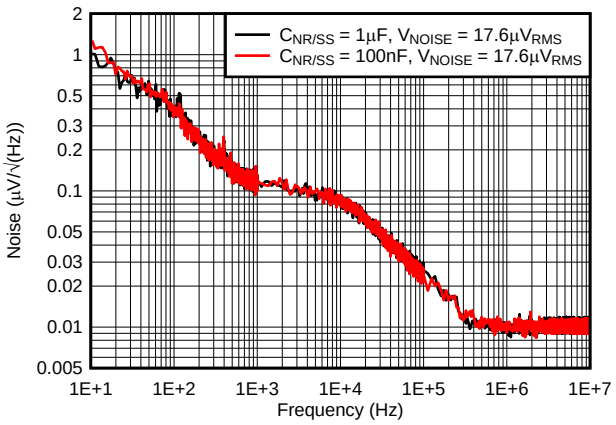
8.2.3 Application Curves

Figure 33 and Figure 34 show typical application performance for PSRR and spectral noise density, respectively, versus $C_{NR/SS}$ with C_{FF}.



V_{IN} = –16 V, V_{OUT} = –15 V, I_{OUT} = 1 A, C_{FF} = 10 nF, C_{OUT} = 2 × 10 µF

Figure 33. Power-Supply Rejection Ratio vs $C_{NR/SS}$ With C_{FF}



V_{IN} = –16 V, V_{OUT} = –15 V, I_{OUT} = 1 A, C_{FF} = 10 nF, C_{OUT} = 2 × µF

Figure 34. Output Spectral Noise Density vs $C_{NR/SS}$ With C_{FF}

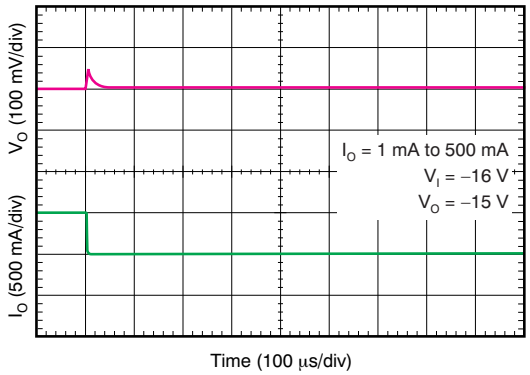


Figure 35. Load Transient

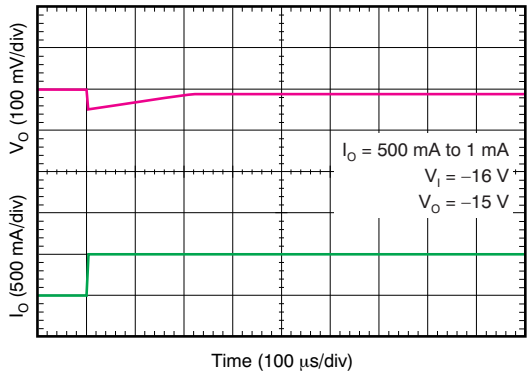


Figure 36. Load Transient

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Typical Application (continued)

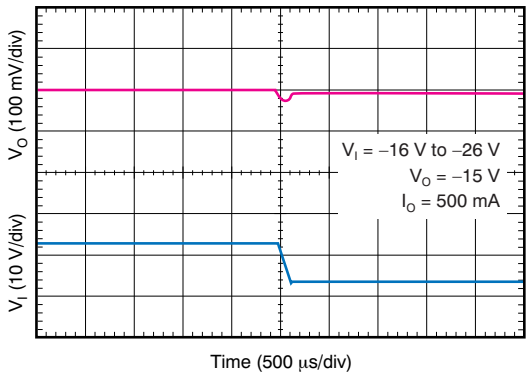


Figure 37. Line Transient

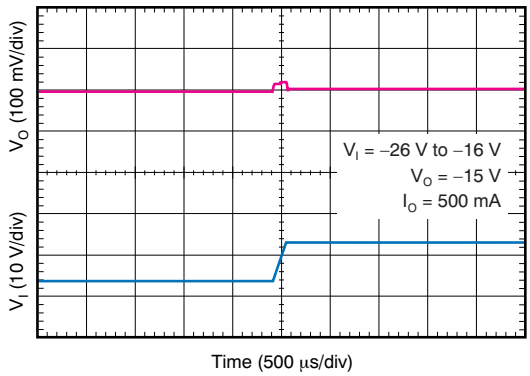


Figure 38. Line Transient

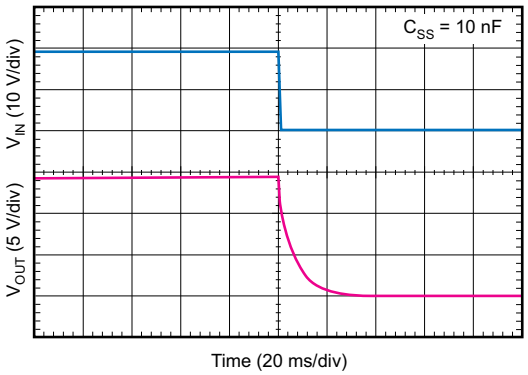


Figure 39. Capacitor-Programmable Soft-Start

8.3 Do's and Don’ts

Place at least one low ESR 10-µF capacitor as close as possible to both the IN and OUT terminals of the regulator to the GND pin.

Provide adequate thermal paths away from the device.

Do not place the input or output capacitor more than 10 mm away from the regulator.

Do not exceed the absolute maximum ratings.

Do not float the EN pin.

Do not resistively or inductively load the NR/SS pin.

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9 Power Supply Recommendations

The input supply for the LDO must be within its recommended operating conditions, from –35 V to –3 V. The input voltage must provide adequate headroom for the device to have a regulated output. If the input supply is noisy, additional input capacitors with low ESR can help improve the output noise performance.

10 Layout

Layout is a critical part of good power-supply design. Several signal paths that conduct fast-changing currents or voltages can interact with stray inductance or parasitic capacitance to generate noise or degrade the power-supply performance. To help eliminate these problems, the IN pin should be bypassed to ground with a low ESR ceramic bypass capacitor with a X5R or X7R dielectric.

10.1 Layout Guidelines

10.1.1 Improve PSRR and Noise Performance

To improve AC performance such as PSRR, output noise, and transient response, TI recommends designing the board with separate planes for IN, OUT, and GND. The IN and OUT planes should be isolated from each other by a GND plane section. In addition, the ground connection for the output capacitor should connect directly to the GND pin of the device.

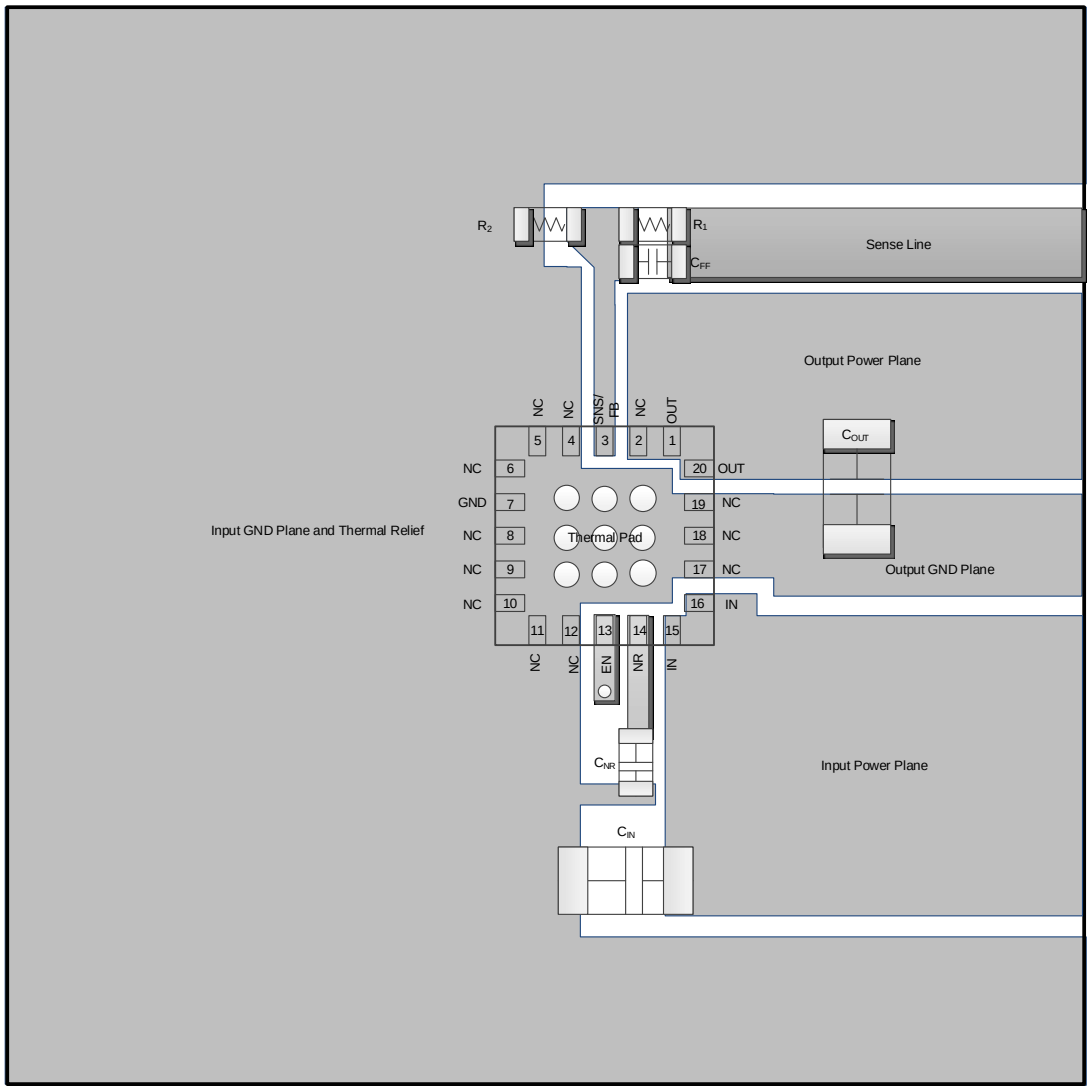
Equivalent series inductance (ESL) and equivalent series resistance (ESR) must be minimized in order to maximize performance and ensure stability. Every capacitor (C_{IN}, C_{OUT}, $C_{NR/SS}$, C_{FF}) must be placed as close as possible to the device and on the same side of the PCB as the regulator itself.

Do not place any of the capacitors on the opposite side of the PCB from where the regulator is installed. The use of vias and long traces is strongly discouraged because they may impact system performance negatively and even cause instability.

10.2 Layout Example

It may be possible to obtain acceptable performance with alternative PCB layouts; however, the layout shown in Figure 41 and the schematic shown in Figure 42 have been shown to produce good results and are meant as a guideline.

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Scale is 8:1
This figure shows a 1x1 layout; expand to 3x3 or at least 2x2.

Figure 40. TPS7A33 5-mm × 5-mm QFN-20 Layout Guideline

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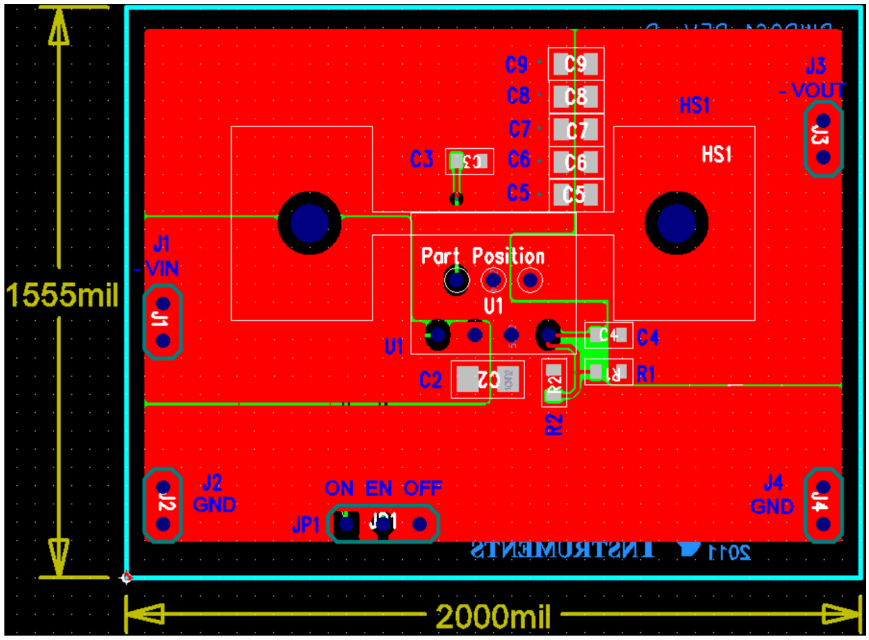


Figure 41. TPS7A33 TO-220 EVM PCB Layout Example: Top Layer

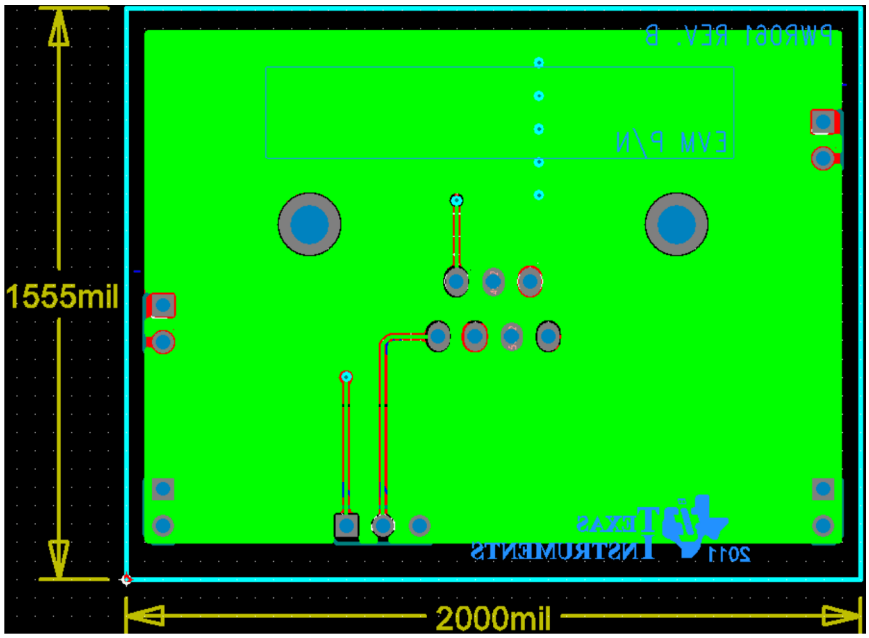


Figure 42. TPS7A33 TO-220 EVM PCB Layout Example: Bottom Layer

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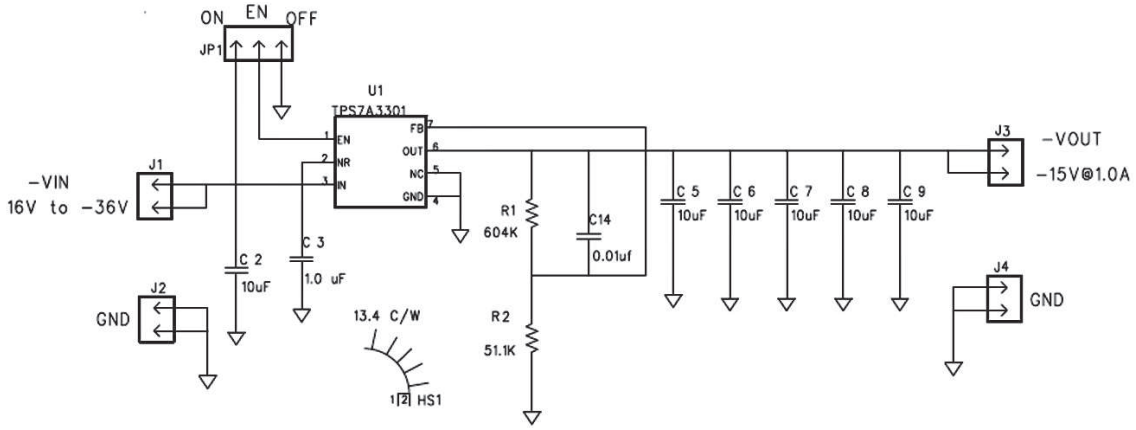


Figure 43. Schematic for TPS7A33 TO-220 EVM PCB Layout Example

10.3 Thermal Performance and Heat Sink Selection

The primary TPS7A33 application is to provide ultralow-noise voltage rails to high-performance analog circuitry in order to maximize system accuracy and precision. The high-current and high-voltage characteristics of this regulator means that, often enough, high power (heat) is dissipated from the device itself. This heat, if dissipated into the PCB (as is the case with SMT packages), creates a temperature gradient in the surrounding area that causes nearby components to react to this temperature change (drift). In high-performance systems, such drift may degrade overall system accuracy and precision.

Compared to surface-mount packages, the TO-220 (KC) package allows for an external heat sink to be used to maximize thermal performance and keep heat from dissipating into the PCB.

The heat generated by the device is a result of the power dissipation, which depends on input voltage and load conditions. Power dissipation (P_D) can be approximated by calculating the product of the output current times the voltage drop across the output pass element, as shown in Equation 4:

$$P_D = (V_{IN} - V_{OUT})\ I_{OUT} \quad (4)$$

Heat flows from the device to the ambient air through many paths, each of which represents resistance to the heat flow; this effect is called thermal resistance.

The total thermal resistance of a system is defined by: $\theta_{JA} = (T_J - T_A)/P_D$; where: θ_{JA} is the thermal resistance (in °C/W), T_J is the allowable juntion temperature of the device (in °C), T_A is the maximum temperature of the ambient cooling air (in °C), and P_D is the amount of power (heat) dissipated by the device (in W).

Whenever a heat sink is installed, the total thermal resistance (θ_{JA}) is the sum of all the individual resistances from the device, going through its case and heatsink to the ambient cooling air ($\theta_{JA} = \theta_{JC} + \theta_{CS} + \theta_{SA}$). Realistically, only two resistances can be controlled: θ_{CS} and θ_{SA}. Therefore, for a device with a known θ_{JC}, θ_{CS} and θ_{SA} become the main design variables in selecting a heat sink.

The thermal interface between the case and the heat sink (θ_{CS}) is controlled by selecting the correct heat-conducting material. Once the θ_{CS} is selected, the required thermal resistance from the heat sink to ambient is calculated by the following equation: $\theta_{SA} = [(T_J - T_A)/P_D] - [\theta_{JC} + \theta_{CS}]$. This information allows the most appropriate heat sink to be selected for any particular application.

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10.4 Package Mounting

The TO-220 (KC) 7-lead, straight-formed package lead spacing poses a challenge when creating a suitable PCB footprint without bending the leads. Component forming pliers can be used to manually bend the package leads into a 7-lead stagger pattern with increased lead spacing that can be more easily used.

The TPS7A33 evaluation board layout can be used as a guideline on suitable PCB footprints, available at www.ti.com. Refer to the TPS7A3301EVM-061 user's guide for more information.

11 器件和文档支持

11.1 器件支持

11.1.1 开发支持

11.1.1.1 评估模块

评估模块 (EVM) 可与 TPS7A33 配套使用，帮助评估初始电路性能。 TPS7A3301EVM-061 评估模块（和相关的用户指南）可在德州仪器 (TI) 网站上的产品文件夹中获取，也可直接从 TI 网上商店购买。

11.1.1.2 Spice 模型

分析模拟电路和系统的性能时，使用 SPICE 模型对电路性能进行计算机仿真非常有用。 您可以从产品文件夹中的*工具和软件*选项卡下获取 TPS7A33 的 SPICE 模型。

11.1.2 器件命名规则

表 **3.** 器件命名规则(1)

产品	V_{OUT}
TPS7A3301**YYY*Z***	**YYY** 为封装标识符。 **Z** 为卷带数量（R = 3000，T = 250）。

(1) 要获得最新的封装和订购信息，请见本文档末尾的封装选项附录，或者访问 TI 网站 www.ti.com。

11.2 文档支持

11.2.1 相关文档

相关文档如下（下载网站 www.ti.com.cn）：

- *使用前馈电容器和低压降稳压器的优缺点*， SBVA042
- 《*TPS7A3301EVM-061 评估模块用户指南*》，SLVU602

11.3 商标

All trademarks are the property of their respective owners.

11.4 静电放电警告



这些装置包含有限的内置 ESD 保护。 存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

11.5 术语表

SLYZ022 — *TI 术语表*。

这份术语表列出并解释术语、首字母缩略词和定义。

12 机械封装和可订购信息

以下页中包括机械封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS7A3301RGWR	ACTIVE	VQFN	RGW	20	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	PXQQ	Samples
TPS7A3301RGWT	ACTIVE	VQFN	RGW	20	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	PXQQ	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

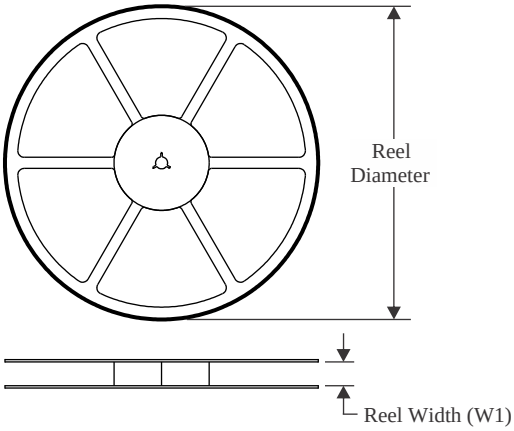
(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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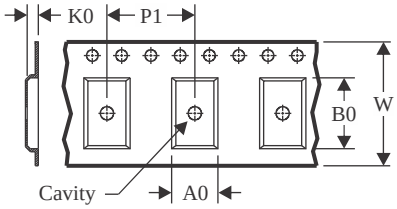
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TAPE AND REEL INFORMATION

REEL DIMENSIONS

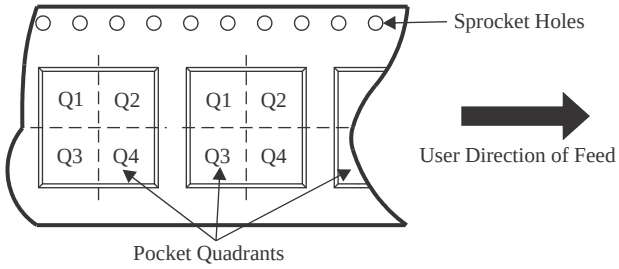


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

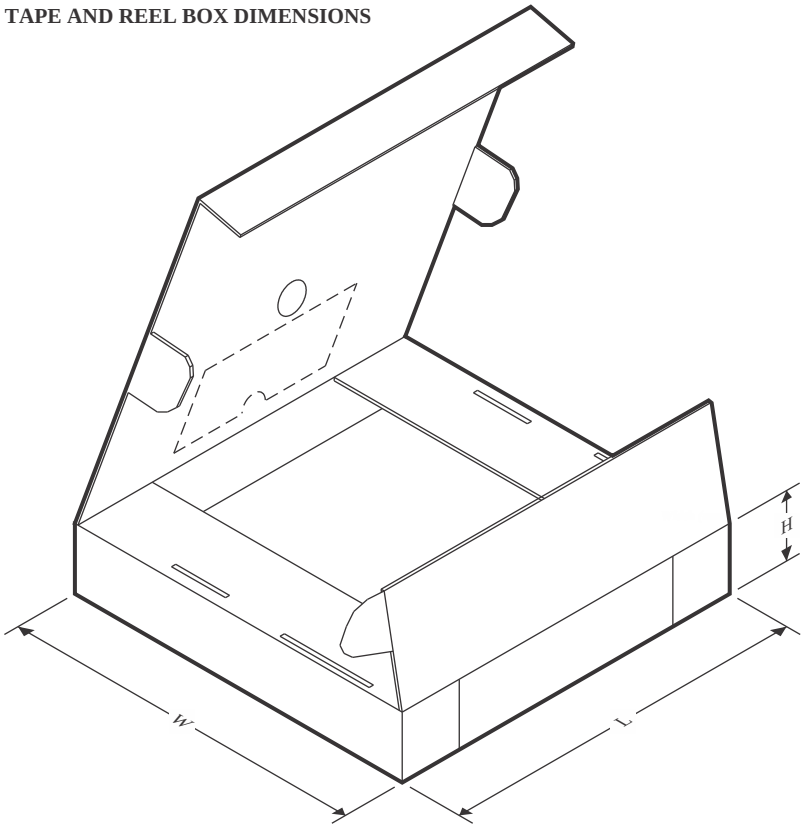
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS7A3301RGWR	VQFN	RGW	20	3000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
TPS7A3301RGWT	VQFN	RGW	20	250	180.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS7A3301RGWR	VQFN	RGW	20	3000	346.0	346.0	33.0
TPS7A3301RGWT	VQFN	RGW	20	250	210.0	185.0	35.0

GENERIC PACKAGE VIEW

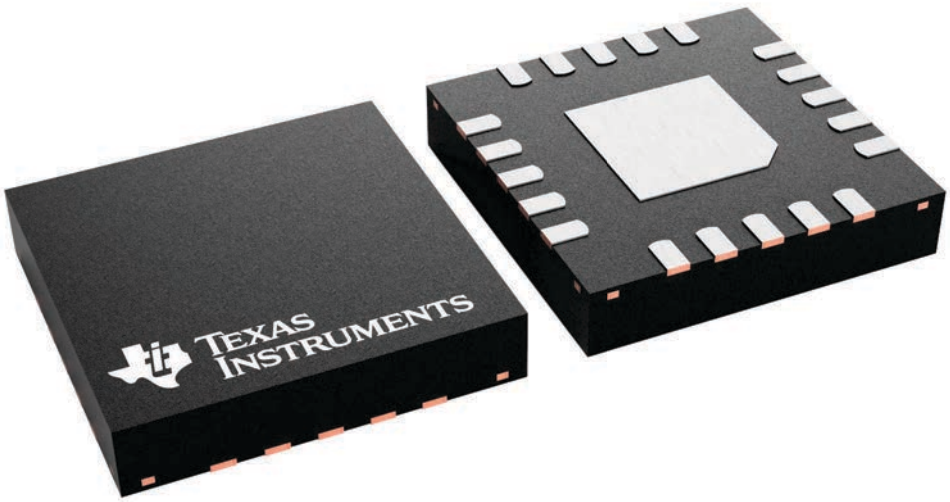
RGW 20

VQFN - 1 mm max height

5 x 5, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4227157/A

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